

## AOLF66417

40V N-Channel AlphaSGT™

## **General Description**

- Trench Power AlphaSGT<sup>TM</sup> technology
- Low R<sub>DS(ON)</sub>
- Wave solderable
- Standard Vgsth Driving
- Excellent Q<sub>q</sub> x R<sub>DS(ON)</sub> Product (FOM)
- RoHS 2.0 and Halogen-Free Compliant

## **Applications**

 High Frequency Switching and Synchronous Rectification

## **Product Summary**

 $\begin{array}{ll} V_{DS} & 40V \\ I_D \; (at \; V_{GS} \!\!=\! 10V) & 200A \\ R_{DS(ON)} \; (at \; V_{GS} \!\!=\! 10V) & < 2.6 m\Omega \end{array}$ 

100% UIS Tested 100% Rg Tested

Max Tj=175°C



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Orderable Part Number	Package Type	Form	Minimum Order Quantity
AOLF66417	LFPAK5X6	Tape & Reel	1500

#### Absolute Maximum Ratings T<sub>A</sub>=25°C unless otherwise noted Parameter Symbol Maximum Units Drain-Source Voltage $V_{DS}$ 40 Gate-Source Voltage ±20 $V_{GS}$ $T_C=25^{\circ}C$ 200 Continuous Drain $I_D$ T<sub>C</sub>=100°C 143 Current Α Pulsed Drain Current <sup>o</sup> 800 $I_{\rm DM}$ T<sub>A</sub>=25°C 38 Continuous Drain Α $I_{DSM}$ T<sub>A</sub>=70°C Current 31 Avalanche Current <sup>C</sup> $I_{AS}$ 59 Α L=0.1mH Avalanche energy 174 mJ EAS T<sub>C</sub>=25°C 214 $P_D$ W T<sub>C</sub>=100°C Power Dissipation <sup>B</sup> 107 T<sub>A</sub>=25°C 7.5 $P_{\mathsf{DSM}}$ W Power Dissipation A T<sub>△</sub>=70°C 5.2 Junction and Storage Temperature Range °C $T_J, T_{STG}$ -55 to 175

Thermal Characteristics									
Parameter		Symbol	Тур	Max	Units				
Maximum Junction-to-Ambient A	t ≤ 10s	$R_{\theta JA}$	15	20	°C/W				
Maximum Junction-to-Ambient AD	Steady-State		40	50	°C/W				
Maximum Junction-to-Case	Steady-State	$R_{\theta JC}$	0.55	0.7	°C/W				



## Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units			
STATIC PARAMETERS										
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$I_D = 250 \mu A, V_{GS} = 0 V$		40			V			
L Zoro Gato Voltago Drain Current	Zero Gate Voltage Drain Current	V <sub>DS</sub> =40V, V <sub>GS</sub> =0V				1	μΑ			
DSS	Zero Gate Voltage Drain Current		T <sub>J</sub> =55°C			5	μΛ			
$I_{GSS}$	Gate-Body leakage current	$V_{DS}$ =0V, $V_{GS}$ =±20V				±100	nA			
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$ , $I_{D}=250\mu A$		2.5	3.15	3.8	V			
	Static Drain-Source On-Resistance	V <sub>GS</sub> =10V, I <sub>D</sub> =20A			2.1	2.6	mΩ			
R <sub>DS(ON)</sub>			T <sub>J</sub> =125°C		3	3.6	11122			
g <sub>FS</sub>	Forward Transconductance	$V_{DS}=5V$ , $I_{D}=20A$			105		S			
$V_{SD}$	Diode Forward Voltage	I <sub>S</sub> =1A, V <sub>GS</sub> =0V			0.7	1	V			
Is	Maximum Body-Diode Continuous Curr	ent			200	Α				
DYNAMIC	PARAMETERS									
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =20V, f=1MHz			3700		pF			
Coss	Output Capacitance				620		pF			
C <sub>rss</sub>	Reverse Transfer Capacitance				45		pF			
$R_g$	Gate resistance	f=1MHz		0.3	0.6	1	Ω			
SWITCHI	NG PARAMETERS									
Q <sub>g</sub> (10V)	Total Gate Charge				43	60	nC			
$Q_{gs}$	Gate Source Charge	V <sub>GS</sub> =10V, V <sub>DS</sub> =20V, I <sub>D</sub> =20A			15		nC			
$Q_{gd}$	Gate Drain Charge				3		nC			
Q <sub>oss</sub>	Output Charge	$V_{GS}=0V$ , $V_{DS}=20V$			24		nC			
t <sub>D(on)</sub>	Turn-On DelayTime				12		ns			
t <sub>r</sub>	Turn-On Rise Time	$V_{GS}$ =10V, $V_{DS}$ =20V, $R_L$ =1.0 $\Omega$ , $R_{GEN}$ =3 $\Omega$			2		ns			
$t_{D(off)}$	Turn-Off DelayTime				27		ns			
t <sub>f</sub>	Turn-Off Fall Time				3		ns			
t <sub>rr</sub>	Body Diode Reverse Recovery Time	I <sub>F</sub> =20A, di/dt=500A/μ			18		ns			
$Q_{rr}$	Body Diode Reverse Recovery Charge	$I_F=20A$ , di/dt=500A/ $\mu$	S		55		nC			

A. The value of R<sub>BJA</sub> is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with T<sub>A</sub> =25° C. The Power dissipation P<sub>DSM</sub> is based on R<sub>BJA</sub> t≤ 10s and the maximum allowed junction temperature of 175° C. The value in any given application depends on the user's specific board design, and the maximum temperature of 175° C may be used if the PCB allows it.

- D. The R<sub>BJA</sub> is the sum of the thermal impedance from junction to case R<sub>BJC</sub> and case to ambient.
- E. The static characteristics in Figures 1 to 6 are obtained using <300µs pulses, duty cycle 0.5% max.

  F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of  $T_{J(MAX)}$ =175° C. The SOA curve provides a single pulse rating.

  G. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with  $T_A$ =25° C.

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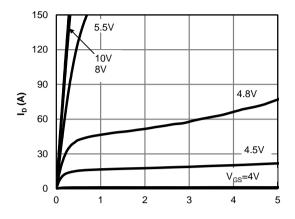
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B. The power dissipation  $P_D$  is based on  $T_{J(MAX)}$ =175° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

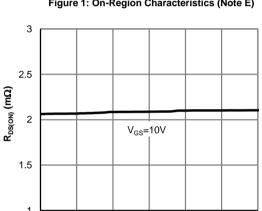
C. Single pulse width limited by junction temperature  $T_{J(MAX)}$ =175° C.



## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



 $V_{\rm DS}$  (Volts) Figure 1: On-Region Characteristics (Note E)



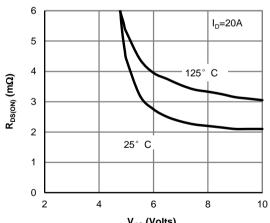
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I<sub>D</sub> (A) Figure 3: On-Resistance vs. Drain Current and Gate Voltage (Note E)

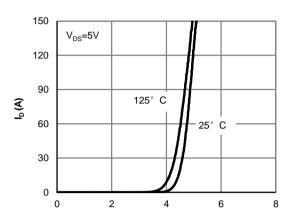
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20

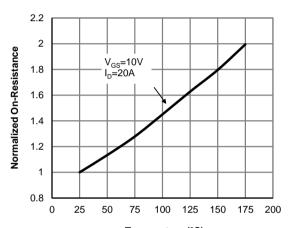
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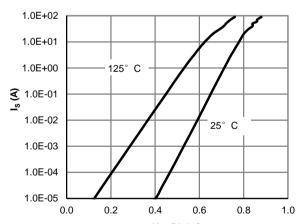
V<sub>GS</sub> (Volts) Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)



V<sub>GS</sub> (Volts) Figure 2: Transfer Characteristics (Note E)



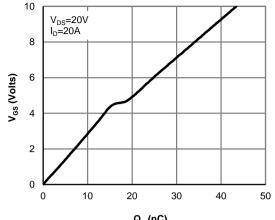
Temperature (°C)
Figure 4: On-Resistance vs. Junction
Temperature (Note E)



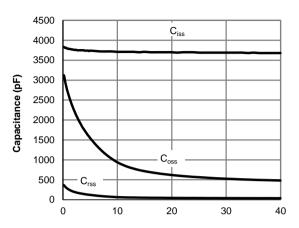
V<sub>SD</sub> (Volts) Figure 6: Body-Diode Characteristics (Note E)



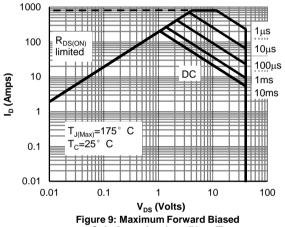
## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



 ${\bf Q_g}$  (nC) Figure 7: Gate-Charge Characteristics



V<sub>DS</sub> (Volts)
Figure 8: Capacitance Characteristics



Safe Operating Area (Note F)

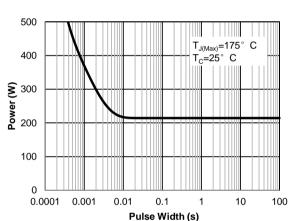
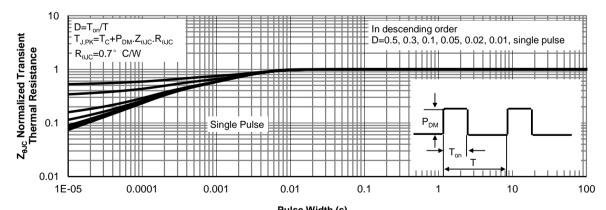


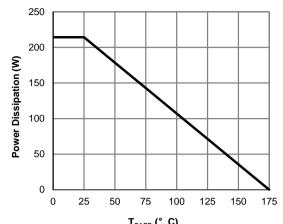
Figure 10: Single Pulse Power Rating Junction-to-Case (Note F)



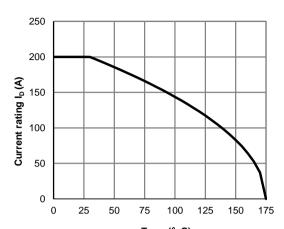
Pulse Width (s)
Figure 11: Normalized Maximum Transient Thermal Impedance (Note F)



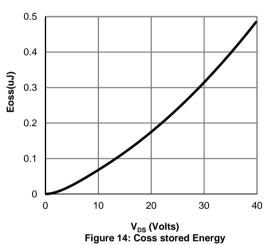
## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

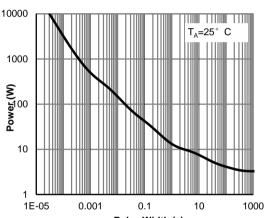


T<sub>CASE</sub> (° C)
Figure 12: Power De-rating (Note F)

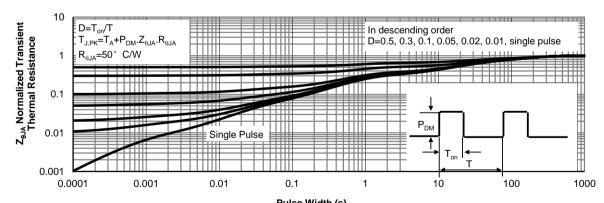


T<sub>CASE</sub> (° C)
Figure 13: Current De-rating (Note F)





Pulse Width (s) Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note G)



Pulse Width (s)
Figure 16: Normalized Maximum Transient Thermal Impedance (Note G)

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Figure A: Gate Charge Test Circuit & Waveforms

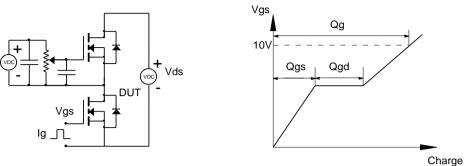


Figure B: Resistive Switching Test Circuit & Waveforms

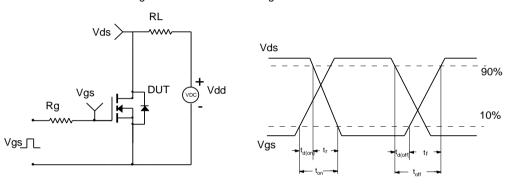


Figure C: Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

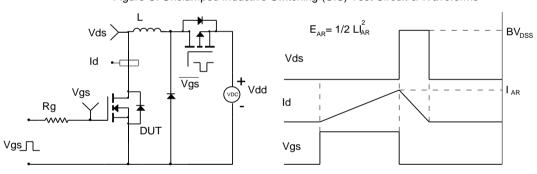
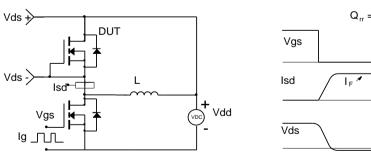
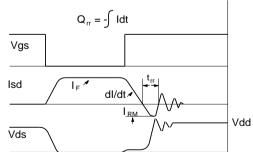


Figure D: Diode Recovery Test Circuit & Waveforms





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